

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination WEI ET AL.	
		Examiner Frederick J. Parker	Art Unit 1762	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,419,849	07-2002	Qiu et al.	252/62.9R
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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